

Substitute Form PTO-1449

U.S. Department of Commerce
Patent and Trademark OfficeAttorney's Docket No.
17979-050001Application No.
09/934,817**Information Disclosure Statement
by Applicant**

(Use several sheets if necessary)

Applicant
Christian Wagner et al.Filing Date
August 21, 2001Group Art Unit
2161

(37 CFR 1.98(b))

U.S. Patent Documents

Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
<i>Edeh</i>	AA	AB	3,587,063	June 22, 1971	Lamberts et al.		
	AC	AD	3,626,176	Dec. 7, 1971	Taisuke Tsugami		
	AE	AF	4,155,631	May 22, 1979	Borsare et al.		
	AG	AH	4,459,016	July 10, 1984	Tokuhara et al.		
	AI	AJ	4,577,305	Mar. 18, 1986	Allen et al.		
	AK	AL	4,595,273	June 17, 1986	Watanabe et al.		
	AM	AN	4,668,077	May 26, 1987	Tanaka		
	AO	AP	4,739,396	April 19, 1988	Hyatt		
	AQ	AR	4,846,578	July 11, 1989	Morita et al.		
	AS	AT	4,855,792	Aug. 8, 1989	Holbrook et al.		
	AU	AV	5,313,333	May 17, 1994	O'Brien et al.		
	AW	AX	5,557,413	Sept. 17, 1996	Ebihara et al.		
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	ACC	ADD	5,741,056	April 21, 1998	Liu		
	AEE	AFF	5,764,312	June 9, 1998	Okumura		
	AGG	AHH	5,805,273	Sept. 8, 1998	Unno		
	AII	AJJ	5,883,704	Mar. 16, 1999	Nishi et al.		
	AKK	ALL	5,953,106	Sept. 14, 1999	Unno et al.		
	AMM	ANN	6,038,013	Mar. 14, 2000	Ohsaki		
	AOO	APP	6,211,896	April 3, 2001	Morton		
	AQQ	ARR	2003/0142785	July 31, 2003	Kageyama		
	ASS	ATT					

Foreign Patent Documents or Published Foreign Patent Applications

Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
<i>Edeh</i>	AUU	EP 0678768	Oct. 25, 1995	Europe				

Examiner Signature

Etienne P. Lehoucq

Date Considered

2/21/2007

EXAMINER: Initials citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Substitute Form PTO-1449 (Modified)	U.S. Department of Commerce Patent and Trademark Office	Attorney's Docket No. 17979-050001	Application No. 09/934,817
Information Disclosure Statement by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))		Applicant Christian Wagner et al.	
		Filing Date August 21, 2001	Group Art Unit 2161

Foreign Patent Documents or Published Foreign Patent Applications								
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation	
							Yes	No
<i>Edeh</i>	AVV	EP 0853357	July 15, 1998	Europe				
	AWW	EP 0938009	Aug. 25, 1999	Europe				no
	AXX	EP 0938009	Aug. 25, 1999	Europe (abstract)			yes	
	AYY	EP 1596235	Nov. 16, 2005	Europe				no
	AZZ	EP 1596235	Nov. 16, 2005	Europe (abstract)			yes	
	AAAA	JP 59150488	Aug. 28, 1984	Japan				no
	ABBB	JP 59150488	Aug. 28, 1984	Japan (abstract)			yes	
	ACCC	JP 59175178	Oct. 3, 1984	Japan				no
	ADDD	JP 59175178	Oct. 3, 1984	Japan (abstract)			yes	
	AEEE	JP 61208002	Sept. 16, 1986	Japan				no
	AFFF	JP 61208002	Sept. 16, 1986	Japan (abstract)			yes	
	AGGG	JP 06003510	Jan. 14, 1994	Japan				no
	AHHH	JP 06003510	Jan. 14, 1994	Japan (abstract)			yes	
	AIII							

Other Documents (include Author, Title, Date, and Place of Publication)		
Examiner Initial	Desig. ID	Document
	AJJJ	
	AKKK	

Examiner Signature <i>Etienne P. Lehoucq</i>	Date Considered <i>2/21/2007</i>
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